

Notice of References CitedApplication No.
08/603,657

Applicant(s)

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2112

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U.S. PATENT DOCUMENTS

*		DOCUMENT NO.	DATE	NAME	CLASS	SUBCLASS
	A	3,260,803	7-1966	MOROISHI	200	6 B
	B	3,251,956	5-1966	RASOR ET AL.	200	14
x	C	2,326,070	8-1943	SCHAECHLIN ET AL.	307	64
x	D	3,614,461	10-1971	SPEAR ET AL	307	64
x	E	3,753,069	8-1993	NEWTON	318	440
x	F	4,157,461	6-1979	WIKTOR	200	18
x	G	4,295,054	10-1981	KOVATCH ET AL.	307	80
x	H	4,371,820	2-1983	KRUGER	318	468
x	I	4,398,097	8-1983	SCHELL ET AL	307	64
x	J	4,423,336	12-1983	IVERSON ET AL	307	64
x	K	4,760,278	7-1988	THOMSON	307	64
x	L	4,937,403	6-1990	MINOURA ET AL	200	50.21
x	M	5,023,469	6-1991	BASSETT ET AL	307	64

FOREIGN PATENT DOCUMENTS

*		DOCUMENT NO.	DATE	COUNTRY	NAME	CLASS	SUBCLASS
	N						
	O						
	P						
	Q						
	R						
	S						
	T						

NON-PATENT DOCUMENTS

*		DOCUMENT (Including Author, Title, Source, and Pertinent Pages)	DATE
	U		
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	X		

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(See Manual of Patent Examining Procedure, Section 707.05(a).)

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U.S. PATENT DOCUMENTS

*		DOCUMENT NO.	DATE	NAME	CLASS	SUBCLASS
x	A	5,048,366	9-1991	SPANIO	74	567
x	B	5,075,517	12-1991	SPANIO	200	16 A
x	C	5,081,367	1-1992	SMITH ET AL.	307	64
x	D	5,200,586	4-1993	SMITH ET AL.	200	50.32
x	E	5,278,369	1-1994	SPANIO	200	243
	F	3,614,363	10-1991	FUJITA	200	303
	G	4,503,412	3-1985	ALSCH	200	14 x
	H	4,724,287	2-1988	HENG ET AL	200	14
	I	4,851,620	7-1989	SCHAEFFER	200	14
	J	4,154,996	5-1979	ARNOLD	200	243
	K					----
	L					
	M					

FOREIGN PATENT DOCUMENTS

*		DOCUMENT NO.	DATE	COUNTRY	NAME	CLASS	SUBCLASS
	N						
	O						
	P						
	Q						
	R						
	S						
	T						

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*		DOCUMENT (Including Author, Title, Source, and Pertinent Pages)	DATE
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	W		
	X		

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